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Patent
Attorney's Docket No. 027260-485

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of
Takehiko SHIMOMURA, et al.

Application No.: 09/939,602

Filed: August 28, 2001

For: SCAN TEST SYSTEM FOR
SEMICONDUCTOR DEVICE

Group Art Unit: 2133

Examiner: Unassigned

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DEC 05 2001
Technology Center 2100

REQUEST FOR CORRECTED OFFICIAL FILING RECEIPT

Assistant Commissioner for Patents
Office of Initial Patent Examination
Customer Service Center
Washington, D.C. 20231

Sir:

Enclosed is a copy of the Official Filing Receipt marked in red to show correction that is needed. The correction is as follows.

Under Foreign Applications, delete [2001-90830] and insert --2001-090830--.

Issuance of a corrected Official Filing Receipt is respectfully requested.

Respectfully submitted,

BURNS, DOANE, SWECKER & MATHIS, L.L.P.

By:


Ellen Marcie Emas
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Date: November 21, 2001



UNITED STATES PATENT AND TRADEMARK OFFICE

COMMISSIONER FOR PATENTS
UNITED STATES PATENT AND TRADEMARK OFFICE
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APPLICATION NUMBER	FILING DATE	GRP ART UNIT	FIL FEE REC'D	ATTY. DOCKET NO	DRAWINGS	TOT CLAIMS	IND CLAIMS
09/939,602	08/28/2001	2133	710	027260-485	4	6	2

CONFIRMATION NO. 3292

FILING RECEIPT



OC000000006803378

Platon N. Mandros
BURNS, DOANE, SWECKER & MATHIS, L.L.P.
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Date Mailed: 09/27/2001

Receipt is acknowledged of this nonprovisional Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Customer Service Center. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

Applicant(s)

Takehiko Shimomura, Tokyo, JAPAN;
Masayuki Konishi, Tokyo, JAPAN;

Domestic Priority data as claimed by applicant

Foreign Applications

JAPAN ~~2001-00830~~ 03/27/2001
2001-090830

If Required, Foreign Filing License Granted 09/27/2001

Projected Publication Date: 10/03/2002

Non-Publication Request: No

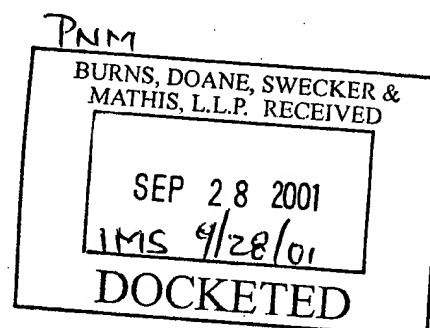
Early Publication Request: No

Title

Scan test system for semiconductor device

Preliminary Class

714



Shingai Patent Office

COPY

Patent
Attorney's Docket No. 027260-485

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In re Patent Application of)	
)	
Takehiko SHIMOMURA et al.)	Group Art Unit: Unassigned
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Application No.: Unassigned)	Examiner: Unassigned
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Filed: August 28, 2001)	
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For: SCAN TEST SYSTEM FOR)	
SEMICONDUCTOR DEVICE)	
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CLAIM FOR CONVENTION PRIORITY

Assistant Commissioner for Patents
Washington, D.C. 20231

Sir:

The benefit of the filing date of the following prior foreign application in the following foreign country is hereby requested, and the right of priority provided in 35 U.S.C. § 119 is hereby claimed:

Japanese Patent Application No. 2001-090830

Filed: March 27, 2001

In support of this claim, enclosed is a certified copy of said prior foreign application. Said prior foreign application was referred to in the oath or declaration. Acknowledgment of receipt of the certified copy is requested.

Respectfully submitted,

BURNS, DOANE, SWECKER & MATHIS, L.L.P.

Date: August 28, 2001

By:

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COPY

PATENT OFFICE
JAPANESE GOVERNMENT

This is to certify that the annexed is a true copy of
the following application as filed with this Office.

Date of Application : March 27, 2001

Application Number : Japanese Patent Application No. 2001-090830

Applicant(s) : MITSUBISHI DENKI KABUSHIKI KAISHA

This 20th day of April, 2001

Commissioner,
Japan Patent Office Kozo OIKAWA

Certificate No. 2001-3032526

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Bib Data Sheet

CONFIRMATION NO. 3292

SERIAL NUMBER 09/939,602	FILING DATE 08/28/2001 RULE	CLASS 714	GROUP ART UNIT 2133	ATTORNEY DOCKET NO. 027260-485	
APPLICANTS Takehiko Shimomura, Tokyo, JAPAN; Masayuki Konishi, Tokyo, JAPAN;					
** CONTINUING DATA ***** <i>none, DG</i>					
** FOREIGN APPLICATIONS ***** <i>DG</i> JAPAN 2001-090830 03/27/2001					
IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 09/27/2001					
Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after met <i>Allowance</i>		STATE OR COUNTRY JAPAN	SHEETS DRAWING 4	TOTAL CLAIMS 6	INDEPENDENT CLAIMS 2
Verified and Acknowledged <i>2009/08/28</i> Examiner's Signature <i>DG</i> Initials					
ADDRESS Platon N. Mandros BURNS, DOANE, SWECKER & MATHIS, L.L.P. P.O. Box 1404 Alexandria, VA 22313-1404					
TITLE Scan test system for semiconductor device					
FILING FEE RECEIVED 710	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit		